

Notice of References Cited

Application/Control No.

09/754,905

Applicant(s)/Patent Under
Reexamination
SYDON ET AL.

Examiner

Steven HD Nguyen

Art Unit

2473

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,515,366	05-1996	Chieu et al.	370/347
*	B	US-5,636,243	06-1997	Tanaka, Syoichi	370/350
*	C	US-5,748,621	05-1998	Masuda et al.	370/350
*	D	US-5,699,409	12-1997	Kojima, Susumu	455/434
*	E	US-5,706,284	01-1998	Lee, Yong-Ho	370/324
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	GB 2285723 A	07-1995	United Kingdom	VAN DEN HEUVEL et al.	H04B 07/26
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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